

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In Re: Wenbing Yun *et al.* Confirmation No: 7844
Application No: 10/683,872 Group: 2872
Filed: October 10, 2003 Examiner: Assaf, Fayeze G.
For: Short Wavelength Metrology
Imaging System
Customer No.: 29127

Attorney Docket No.	0002.0004.us
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AMENDMENT UNDER RULE 312

Commissioner for Patents

P.O. Box 1450

Alexandria, Virginia 22313-1450

Sir:

In response to the Notice of Allowability mailed June 19, 2007 (Paper No. 20070609), please amend the above-captioned patent application as follows:

-amendments to the claims are reflected in the listing of claims in the Listing of Claims section;

Finally, reconsideration is requested in view of the remarks set forth in the Remarks section.